

STF7N95K3 STP7N95K3, **STW7N95K3**

N-channel 950 V, 1.1 Ω, 7.2 A, TO-220, TO-220FP, TO-247 Zener-protected SuperMESH3™ Power MOSFET

Features

Туре	V _{DSS}	R _{DS(on)} max	I _D	Pw
STF7N95K3	950 V	< 1.35 Ω	7.2 A	35 W
STP7N95K3	950 V	< 1.35 Ω	7.2 A	150 W
STW7N95K3	950 V	< 1.35 Ω	7.2 A	150 W

- 100% avalanche tested
- Extremely large avalanche performance
- Gate charge minimized
- Very low intrinsic capacitances
- Zener-protected



■ Switching applications

Description

The new SuperMESH3™ series is obtained through the combination of a further fine tuning of ST's well established strip-based PowerMESH™ layout with a new optimized vertical structure. In addition to pushing on-resistance significantly down, special attention has been taken to ensure a very good dynamic performances coupled with a very large avalanche capability for the most demanding application.

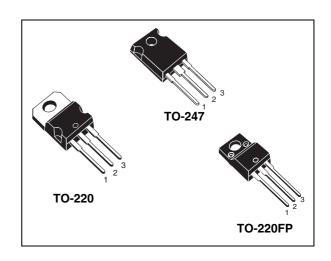


Figure 1. Internal schematic diagram

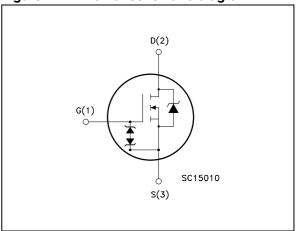


Table 1. Device summary

Order codes	Marking	Package	Packaging
STF7N95K3	7N95K3	TO-220FP	Tube
STP7N95K3	7N95K3	TO-220	Tube
STW7N95K3	7N95K3	TO-247	Tube

January 2009 Rev 1 1/15

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1 Electrical ratings

Table 2. Absolute maximum ratings

Cumbal	Boundary	Value	Unit	
Symbol	Parameter	TO-220, TO-247 TO-220		Ullit
V _{GS}	Gate-source voltage	± 30		V
I _D	Drain current (continuous) at T _C = 25 °C	7.2	7.2 ⁽¹⁾	Α
I _D	Drain current (continuous) at T _C = 100 °C	4.5	4.5 ⁽¹⁾	Α
I _{DM} ⁽²⁾	Drain current (pulsed)	28.8 28.8 ⁽¹⁾		Α
P _{TOT}	Total dissipation at T _C = 25 °C	150	35	W
I _{AR}	Max current during repetitive or single pulse avalanche (pulse width limited by T _{JMAX})	9		Α
E _{AS}	Single pulse avalanche energy (3)	220		mJ
	Derating factor	1.12	0.24	W/°C
dv/dt (4)	Peak diode recovery voltage slope	6		V/ns
V _{ISO}	Insulation withstand voltage (RMS) from all three leads to external heat sink (t=1 s;T _C =25 °C)	2000		V
T _j T _{stg}	Operating junction temperature Storage temperature	-55 to 15	50	°C

- 1. Limited by package
- 2. Pulse width limited by safe operating area
- 3. Starting $T_j = 25$ °C, $I_D = I_{AR}$, $V_{DD} = 50$ V
- 4. $I_{SD} \leq 7.2 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}, V_{Peak} < V_{(BR)DSS}$

Table 3. Thermal data

Symbol	Parameter	Parameter TO-220 TO-247		TO-220FP	Unit
R _{thj-case}	Thermal resistance junction-case max	0.	83	3.57	°C/W
Rt _{hj-amb}	Thermal resistance junction-ambient max	62.5	50	62.5	°C/W
T _I	Maximum lead temperature for soldering purpose		300		°C

2 Electrical characteristics

(Tcase = 25 °C unless otherwise specified)

Table 4. On /off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	I _D = 1 mA, V _{GS} = 0	950			V
I _{DSS}	Zero gate voltage drain current (V _{GS} = 0)	V _{DS} = Max rating V _{DS} = Max rating, T _C =125 °C			1 50	μ Α μ Α
I _{GSS}	Gate-body leakage current (V _{DS} = 0)	V _{GS} = ± 20 V			10	μΑ
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 100 \mu A$	3	4	5	V
R _{DS(on)}	Static drain-source on resistance	$V_{GS} = 10 \text{ V}, I_D = 3.6 \text{ A}$		1.1	1.35	Ω

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
9 _{fs} ⁽¹⁾	Forward transconductance	V _{DS} = 15 V, I _D = 3.6 A		5		S
C _{iss} C _{oss} C _{rss}	Input capacitance Output capacitance Reverse transfer capacitance	$V_{DS} = 100 \text{ V, f} = 1 \text{ MHz,}$ $V_{GS} = 0$		1031 79 0.9		pF pF pF
C _{o(tr)} ⁽²⁾	Equivalent capacitance time related	V _{DS} = 0 to 760 V, V _{GS} = 0		60		pF
C _{o(er)} (3)	Equivalent capacitance energy related	V _{DS} = 0 to 760 V, V _{GS} = 0		36		pF
R _G	Gate input resistance	f=1 MHz Gate DC Bias=0 Test signal level = 20 mV open drain		2.4		Ω
Qg	Total gate charge	$V_{DD} = 760 \text{ V}, I_D = 7.2 \text{ A},$		34		nC
Q_{gs}	Gate-source charge	V _{GS} = 10 V		6		nC
Q_{gd}	Gate-drain charge	(see Figure 20)		20		nC

^{1.} Pulsed: pulse duration = 300 μs, duty cycle 1.5%

^{2.} $C_{oss\,eq}$ time related is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}

^{3.} $C_{oss\ eq.}$ energy related is defined as a constant equivalent capacitance giving the same stored energy as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}

Table 6. Switching times

;	Symbol	Parameter	Test conditions	Min.	Тур.	Max	Unit
	$\begin{array}{c} t_{d(on)} \\ t_{r} \\ t_{d(off)} \\ t_{f} \end{array}$	Turn-on delay time Rise time Turn-off-delay time Fall time	$V_{DD} = 475 \text{ V}, I_D = 3.6 \text{ A},$ $R_G = 4.7 \Omega, V_{GS} = 10 \text{ V}$ (see <i>Figure 19</i>)		14 9 36 23		ns ns ns ns

Table 7. Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current Source-drain current (pulsed)				7.2 28.8	A A
V _{SD} ⁽²⁾	Forward on voltage	I _{SD} = 7.2 A, V _{GS} = 0			1.6	V
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	I _{SD} = 7.2 A, di/dt = 100A/μs V _{DD} = 60 V (see <i>Figure 24</i>)		450 6 28		ns µC A
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD} = 7.2 \text{ A, di/dt} = 100 \text{ A/µs}$ $V_{DD} = 60 \text{ V, T}_j = 150 ^{\circ}\text{C}$ (see <i>Figure 24</i>)		550 8 28		ns µC A

^{1.} Pulse width limited by safe operating area

Table 8. Gate-source Zener diode

Sym	bol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
BV _{GS}	so ⁽¹⁾	Gate-source breakdown voltage	lgs=± 1mA (open drain)	30			٧

The built-in back-to-back Zener diodes have specifically been designed to enhance not only the device's ESD capability, but also to make them safely absorb possible voltage transients that may occasionally be applied from gate to source. In this respect the Zener voltage is appropriate to achieve an efficient and cost-effective intervention to protect the device's integrity. These integrated Zener diodes thus avoid the usage of external components

^{2.} Pulsed: Pulse duration = 300 μ s, duty cycle 1.5%

2.1 Electrical characteristics (curves)

Figure 2. Safe operating area for TO-220 Figure 3. Thermal impedance for TO-220

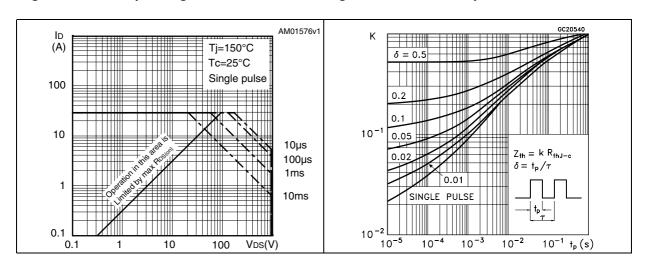


Figure 4. Safe operating area for TO-220FP Figure 5. Thermal impedance for TO-220FP

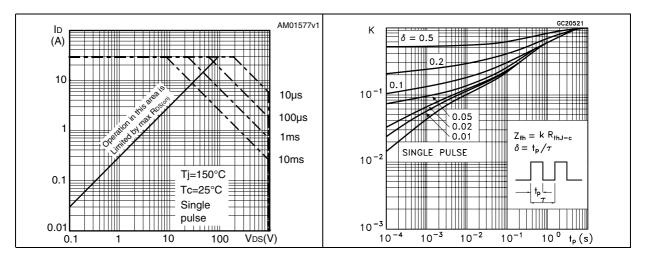
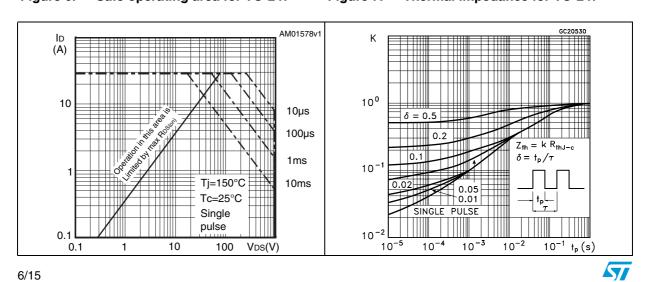


Figure 6. Safe operating area for TO-247 Figure 7. Thermal impedance for TO-247



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Figure 8. Output characteristics

Figure 9. Transfer characteristics

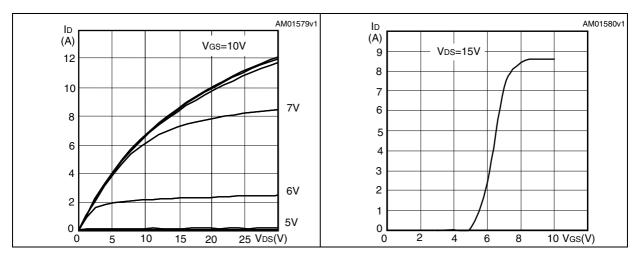


Figure 10. Normalized B_{VDSS} vs temperature

Figure 11. Static drain-source on resistance

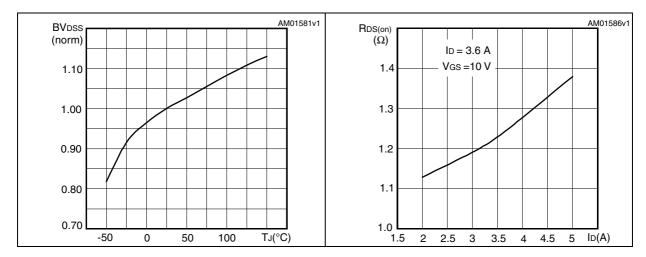


Figure 12. Gate charge vs gate-source voltage Figure 13. Capacitance variations

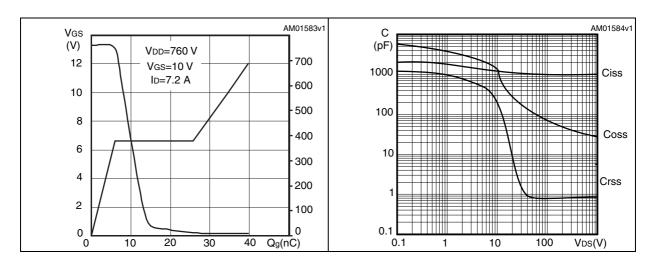
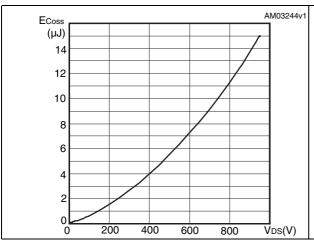


Figure 14. Output capacitance stored energy Figure 15. Normalized on resistance vs temperature



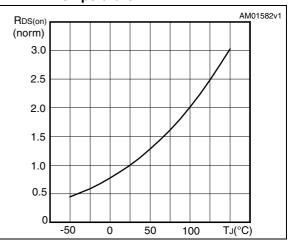
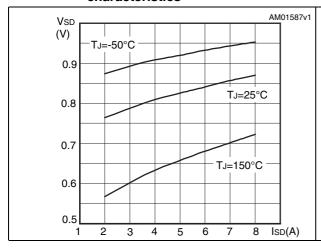


Figure 16. Source-drain diode forward characteristics

Figure 17. Normalized gate threshold voltage vs temperature



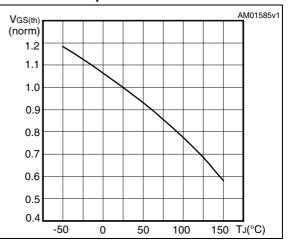
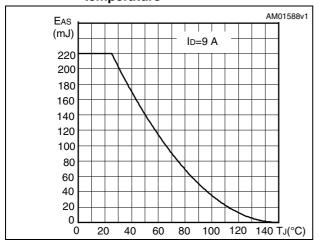


Figure 18. Maximum avalanche energy vs temperature



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3 Test circuits

Figure 19. Switching times test circuit for resistive load

Figure 20. Gate charge test circuit

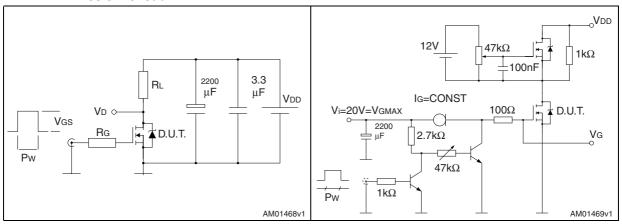


Figure 21. Test circuit for inductive load switching and diode recovery times

Figure 22. Unclamped inductive load test circuit

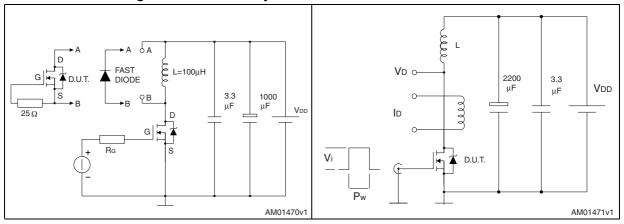
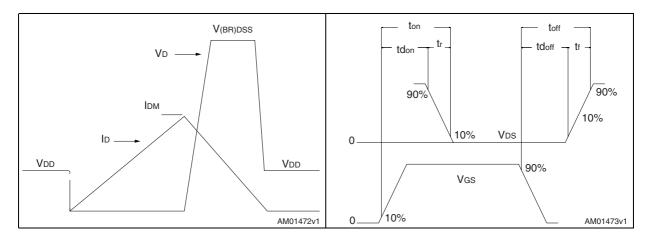


Figure 23. Unclamped inductive waveform

Figure 24. Switching time waveform

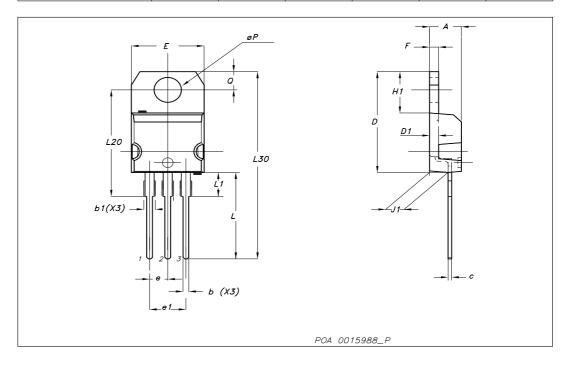


4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: www.st.com. ECOPACK® is an ST trademark.

TO-220 mechanical data

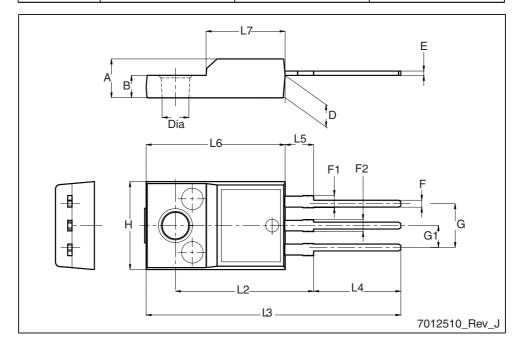
Di		mm			inch	
Dim	Min	Тур	Max	Min	Тур	Max
Α	4.40		4.60	0.173		0.181
b	0.61		0.88	0.024		0.034
b1	1.14		1.70	0.044		0.066
С	0.49		0.70	0.019		0.027
D	15.25		15.75	0.6		0.62
D1		1.27			0.050	
E	10		10.40	0.393		0.409
е	2.40		2.70	0.094		0.106
e1	4.95		5.15	0.194		0.202
F	1.23		1.32	0.048		0.051
H1	6.20		6.60	0.244		0.256
J1	2.40		2.72	0.094		0.107
L	13		14	0.511		0.551
L1	3.50		3.93	0.137		0.154
L20		16.40			0.645	
L30		28.90			1.137	
ØP	3.75		3.85	0.147		0.151
Q	2.65		2.95	0.104		0.116



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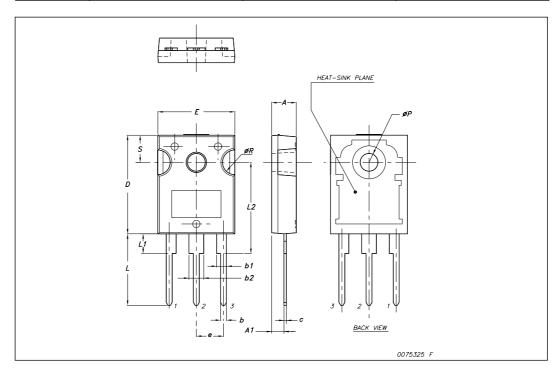
TO-220FP mechanical data

Dim		mm				
Dim.	Min.	Тур.	Max.			
А	4.4		4.6			
В	2.5		2.7			
D	2.5		2.75			
Е	0.45		0.7			
F	0.75		1			
F1	1.15		1.70			
F2	1.15		1.5			
G	4.95		5.2			
G1	2.4		2.7			
Н	10		10.4			
L2		16				
L3	28.6		30.6			
L4	9.8		10.6			
L5	2.9		3.6			
L6	15.9		16.4			
L7	9		9.3			
Dia	3		3.2			



TO-247 Mechanical data

Dim.	mm.		
	Min.	Тур	Max.
Α	4.85		5.15
A1	2.20		2.60
b	1.0		1.40
b1	2.0		2.40
b2	3.0		3.40
С	0.40		0.80
D	19.85		20.15
E	15.45		15.75
е		5.45	
L	14.20		14.80
L1	3.70		4.30
L2		18.50	
øΡ	3.55		3.65
øR	4.50		5.50
S		5.50	



5 Revision history

Table 9. Document revision history

Date	Revision	Changes
27-Jan-2009	1	First release

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